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FORM PTO-1449U.S. DEPARTMENT OF COMMERCE					ATTY. DOCK AFC-002/RE	1	APPLICATION NO. 10/729,582			
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SP	A	Slides 13 and 14 taken from "Precision Microcomb Design and Fabrication for X-ray Optics Assembly Yanxia Sun, R. K. Heilmann, C. G. Chen, C. R. Forest, and M. L. Schattenburg, Space Nanotechnology Laboratory Center for Space Research, MIT, May 29, 2003", downloaded from the internet at: "http://snl.mit.edu/papers/presentations/2003/YSun/3-beam-poster v3.pdf#search=%22drie%20etching%22".								
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